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# AO4419 30V P-Channel MOSFET

# **General Description**

The AO4419 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{\rm DS(ON)}$ . This device is ideal for load switch and battery protection applications.

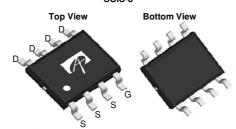
# **Product Summary**

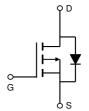
 $\begin{array}{lll} V_{DS} & -30V \\ I_{D} \; (at \; V_{GS} \!\!=\! \!\! -10V) & -9.7A \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -10V) & < 20m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -4.5V) & < 35m\Omega \end{array}$ 

100% UIS Tested 100% R<sub>g</sub> Tested



#### SOIC-8





# Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted

| Parameter                               |                     | Symbol                            | Maximum    | Units |  |
|---|---------------------|-----------------------------------|------------|-------|--|
| Drain-Source Voltage                    |                     | V <sub>DS</sub>                   | -30        | V     |  |
| Gate-Source Voltage                     |                     | V <sub>GS</sub>                   | ±20        | V     |  |
| Continuous Drain<br>Current             | T <sub>A</sub> =25℃ | 1                                 | -9.7       |       |  |
|   | T <sub>A</sub> =70℃ | 'D                                | -7.8       | A     |  |
| Pulsed Drain Current <sup>Ċ</sup>       |                     | I <sub>DM</sub>                   | -70        |       |  |
| Avalanche Current <sup>C</sup>          |                     | I <sub>AS</sub> , I <sub>AR</sub> | -27        | Α     |  |
| Avalanche energy L=0.1mH <sup>C</sup>   |                     | E <sub>AS</sub> , E <sub>AR</sub> | 36         | mJ    |  |
|   | T <sub>A</sub> =25℃ | ь                                 | 3.1        | W     |  |
| Power Dissipation B T <sub>A</sub> =70℃ |                     | $P_{D}$                           | 2          |       |  |
| Junction and Storage Temperature Range  |                     | T <sub>J</sub> , T <sub>STG</sub> | -55 to 150 | C     |  |

| Thermal Characteristics               |              |                 |     |       |     |  |  |  |
|---------------------------------------|--------------|-----------------|-----|-------|-----|--|--|--|
| Parameter                             | Symbol       | Тур             | Max | Units |     |  |  |  |
| Maximum Junction-to-Ambient A         | t ≤ 10s      | B               | 31  | 40    | €/M |  |  |  |
| Maximum Junction-to-Ambient AD        | Steady-State | $n_{\theta JA}$ | 59  | 75    | €/M |  |  |  |
| Maximum Junction-to-Lead Steady-State |              | $R_{\theta JL}$ | 16  | 24    | €\M |  |  |  |



# Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

| Symbol                | Parameter                              | Conditions  | Min  | Тур   | Max  | Units |  |  |  |
|-----------------------|--|---|------|-------|------|-------|--|--|--|
| STATIC PARAMETERS     |  |   |      |       |      |       |  |  |  |
| BV <sub>DSS</sub>     | Drain-Source Breakdown Voltage         | $I_D = -250 \mu A, V_{GS} = 0 V$                                    | -30  |       |      | V     |  |  |  |
| I <sub>DSS</sub>      | Zero Gate Voltage Drain Current        | $V_{DS}$ =-30V, $V_{GS}$ =0V  |      |       | -1   | μΑ    |  |  |  |
|                       |  | T <sub>J</sub> =55℃   |      |       | -5   |       |  |  |  |
| I <sub>GSS</sub>      | Gate-Body leakage current              | $V_{DS}$ =0V, $V_{GS}$ = ±20V                                       |      |       | ±100 | nA    |  |  |  |
| $V_{GS(th)}$          | Gate Threshold Voltage                 | $V_{DS}=V_{GS}$ $I_{D}=-250\mu A$                                   | -1.5 | -2.0  | -2.5 | V     |  |  |  |
| I <sub>D(ON)</sub>    | On state drain current                 | $V_{GS}$ =-10V, $V_{DS}$ =-5V                                       | -70  |       |      | Α     |  |  |  |
|                       | Static Drain-Source On-Resistance      | V <sub>GS</sub> =-10V, I <sub>D</sub> =-9.7A                        |      | 16.5  | 20   |       |  |  |  |
|                       |  | T <sub>J</sub> =125℃  |      | 24    | 29   | mΩ    |  |  |  |
|                       |  | $V_{GS}$ =-4.5V, $I_D$ =-7A   |      | 26    | 35   | mΩ    |  |  |  |
| g <sub>FS</sub>       | Forward Transconductance               | $V_{DS}$ =-5V, $I_D$ =-9.7A   |      | 27    |      | S     |  |  |  |
| $V_{SD}$              | Diode Forward Voltage                  | I <sub>S</sub> =-1A,V <sub>GS</sub> =0V                             |      | -0.75 | -1   | V     |  |  |  |
| Is                    | Maximum Body-Diode Continuous Curr     |   |      | -4    | Α    |       |  |  |  |
| I <sub>SM</sub>       | Pulsed Body-Diode Current <sup>C</sup> |   |      |       | -70  | Α     |  |  |  |
| DYNAMIC               | PARAMETERS                             |   |      |       |      |       |  |  |  |
| C <sub>iss</sub>      | Input Capacitance                      |   |      | 1040  |      | pF    |  |  |  |
| C <sub>oss</sub>      | Output Capacitance                     | $V_{GS}$ =0V, $V_{DS}$ =-15V, f=1MHz                                |      | 180   |      | pF    |  |  |  |
| $C_{rss}$             | Reverse Transfer Capacitance           |   |      | 125   |      | pF    |  |  |  |
| $R_g$                 | Gate resistance                        | $V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz                                  | 2    | 4     | 6    | Ω     |  |  |  |
| SWITCHII              | NG PARAMETERS                          |   |      |       |      |       |  |  |  |
| Q <sub>g</sub> (10V)  | Total Gate Charge                      |   |      | 19    |      | nC    |  |  |  |
| Q <sub>g</sub> (4.5V) | Total Gate Charge                      | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-9.7A |      | 9.6   |      | nC    |  |  |  |
| $Q_{gs}$              | Gate Source Charge                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-13V, I <sub>D</sub> =-9.7A |      | 3.6   |      | nC    |  |  |  |
| $Q_{gd}$              | Gate Drain Charge                      |   |      | 4.6   |      | nC    |  |  |  |
| t <sub>D(on)</sub>    | Turn-On DelayTime                      |   |      | 10    |      | ns    |  |  |  |
| t <sub>r</sub>        | Turn-On Rise Time                      | $V_{GS}$ =-10V, $V_{DS}$ =-15V, $R_L$ =1.5 $\Omega$ ,               |      | 5.5   |      | ns    |  |  |  |
| $t_{D(off)}$          | Turn-Off DelayTime                     | $R_{GEN}=3\Omega$   |      | 26    |      | ns    |  |  |  |
| t <sub>f</sub>        | Turn-Off Fall Time                     |   |      | 9     |      | ns    |  |  |  |
| t <sub>rr</sub>       | Body Diode Reverse Recovery Time       | I <sub>F</sub> =-9.7A, dI/dt=500A/μs                                |      | 11.5  |      | ns    |  |  |  |
| $Q_{rr}$              | Body Diode Reverse Recovery Charge     | I <sub>F</sub> =-9.7A, dI/dt=500A/μs                                |      | 25    |      | nC    |  |  |  |

A. The value of  $R_{\theta,A}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using  $\leq$  10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial  $T_J=25$ °C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on  $1 \text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150$ °C. The SOA curve provides a single pulse ratin g.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

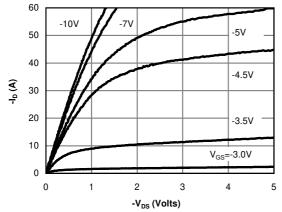


Fig 1: On-Region Characteristics (Note E)

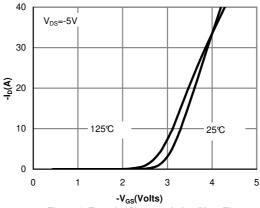


Figure 2: Transfer Characteristics (Note E)

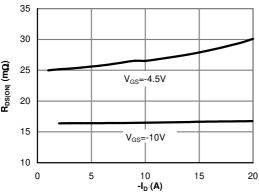


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

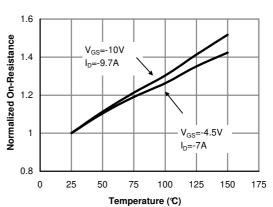


Figure 4: On-Resistance vs. Junction Temperature (Note E)

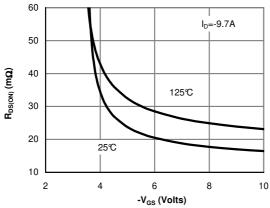


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

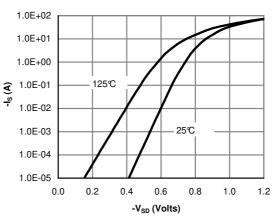


Figure 6: Body-Diode Characteristics (Note E)



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

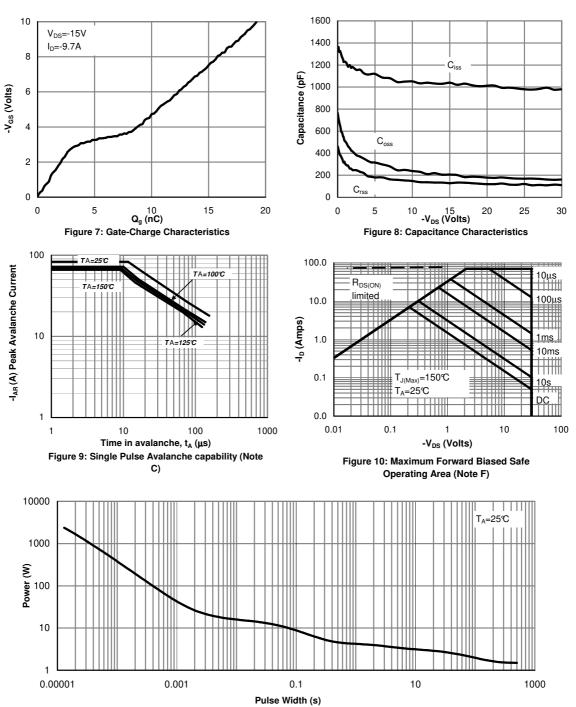
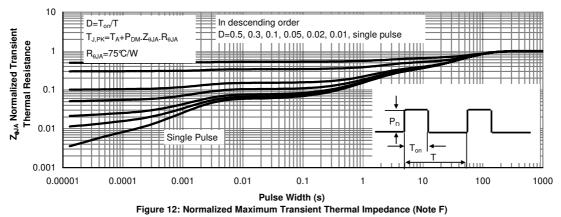


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

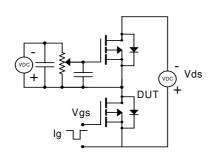


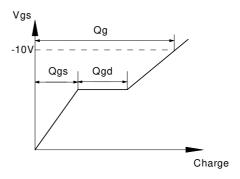
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



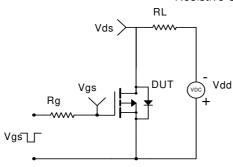


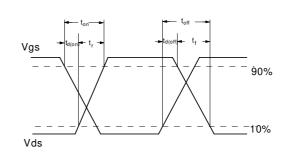
# Gate Charge Test Circuit & Waveform



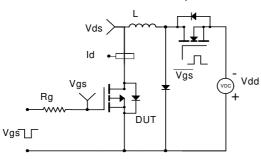


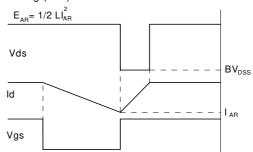
# Resistive Switching Test Circuit & Waveforms





### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





#### Diode Recovery Test Circuit & Waveforms

